Search	Notes	(continue	d)
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Application/Control No.	Applicant(s)/Patent under Reexamination
09/667,237	REINL ET AL.
Examiner	Art Unit
Mark L. Shibuya	1639

SEARCHED			
Class	Subclass	Date	Examiner
			-

INI	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
	1			

SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
PALM	2/23/2005	MS
WEST	2/23/2005	MS
STN, inventor, term search	2/23/2005	MS
WEST, term, inventor search	8/19/2005	MS
STN	8/19/2005	MS
Considered 60/155,978	8/19/2005	MS
SEQ ID 12, STIC nt search	8/19/2005	Mg
(onsidered 09/539,382; 10/067,790; 10/067,892; 10/067,893		mg